


<b>Search Notes</b> 	<b>Application/Control No.</b> 10775957	<b>Applicant(s)/Patent Under Reexamination</b> BHUSHAN ET AL.
	<b>Examiner</b> Hanh Nguyen	<b>Art Unit</b> 2416

SEARCHED			
Class	Subclass	Date	Examiner
455	452.1	1/29/08	hn
	450		
	452.2		
	33.4		
	56.1		
	266		
	512		
455	464		
370	329		
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	332		
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	432		
	320		
370	318	1/29/08	hn

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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